Engineering transcription-based digital logic devices

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vice design and performance.

Goal

Implement *in vivo* combinational digital logic using transcription-based devices.





input swing

Figure 4: The swing, noise margin and trip point are the key metrics of device performance [1, 3]. Ideal devices maximize the noise margin and have a trip point close to half the device swing.

Question: What swing and noise margin do we need for reliable *in vivo* operation of transcription-based logic devices?

Noise in device signals lead to errors



0М 1pM 10pM 100pM 1nM 10nM 100nM 1uM 10uM 50uM **[AHL]**

Figure 7: Normalized fluorescence versus inducer concentration for inverters BBa_Q20060.

In vitro transcriptional repression



Figure 8: Preincubation of protein and regulatory region results in transcriptional repression.

Repressor expression is high

Figure 1: NOT devices can be implemented using 4 parts: an RBS (ribosome binding site), CDS (coding sequence), terminator and regulatory region.

Biological implementation



Figure 2: The CDS encodes a repressor that binds DNA (to repress transcription) and dimerizes (to exhibit cooperativity). The regulatory region binds repressor and has -35 and -10 sites that bind RNA polymerase to initiate transcription.

0.5 1 1.5 Output signal (PoPS)

Figure 5: Device output signals are log-normally distributed [2]. Overlap in the signal distributions for logical 0 and logical 1 can lead to errors.

Error rate as a function of swing





Figure 9: The repressor is expressed at high levels *in vivo*.

Future work

1. Improve repression *in vivo*.

2. Demonstrate scalability of design.

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Figure 3: Static device function is described by a transfer characteristic: a plot of device output versus device input.



Figure 6: The device error rate decreases as swing increases.

Answer: The target device swing depends on the error rate we can tolerate in device operation. It is likely to vary according to the application. We need to choose an acceptable device error rate.

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